Application/Control No. Applicant(s)/Patent Under Reexamination 10/575,675 KHRUSHCHEV ET AL. Notice of References Cited Examiner Art Unit AM 10/07 Page 1 of 1 Quyen P. Leung 2874 **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY Α US-6,563,995 05-2003 Keaton et al. 385/127 US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Germany WILL et al. DE 10155492 A1 10-2003 Ν JP 06224510 A 08-1994 KATO et al. 0 Japan Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) English language translation of DE 101 55 492 completed 12/13/07. W

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